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# NOA1302

## Ambient Light Sensor with I<sup>2</sup>C Interface

### Description

The NOA1302 integrates a wide dynamic range ambient light sensor (ALS) with a 16-bit ADC and a 2-wire I<sup>2</sup>C digital interface. The NOA1302 ambient light sensor provides a linear response over the range of close to 0 lux to well over 100,000 lux with programmable integration times to optimize noise performance. The sensor employs proprietary CMOS image sensing technology from ON Semiconductor which provides low noise and high dynamic range output signals and light response similar to the response of the human eye.

The NOA1302 operates as an I<sup>2</sup>C slave device and supports commands to set options in the device and read out the ambient light intensity count.

### Features

- Senses Ambient Light and Provides an Output Count Proportional to the Ambient Light Intensity
- Human Eye Type of Spectral Response
- Provides Comfortable Levels of Display Depending on the Viewing Environment
- Linear Response Over the Full Operating Range
- Senses Intensity of Ambient Light from ~0 Lux to over 100,000 Lux
- Programmable Integration Times of 400 ms, 200 ms and 100 ms
- No External Components Required
- Low Power Consumption
- Built-in 16-bit ADC
- I<sup>2</sup>C Serial Communication Port – Standard Mode – 100 kHz  
– Fast Mode – 400 kHz
- This Device is Pb-Free, Halogen Free/BFR Free, and RoHS Compliant

### Applications

- Saves Display Power in Applications such as:
  - Laptops, Notebooks, Digital Signage
  - LCD TVs and Monitors, Digital Picture Frames
  - LED Indoor/Outdoor Residential and Street Lights

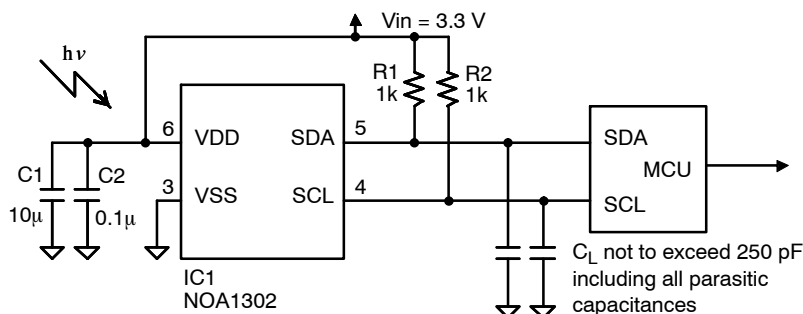
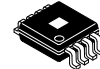


Figure 1. Typical Application Circuit



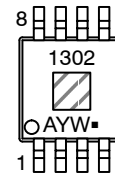
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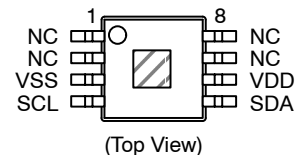
CTSSOP-8  
DC SUFFIX  
CASE 949AA

### MARKING DIAGRAM



1302= Specific Device Code  
A = Assembly Location  
Y = Year  
W = Work Week  
▪ = Pb-Free Package

### PIN ASSIGNMENT



### ORDERING INFORMATION

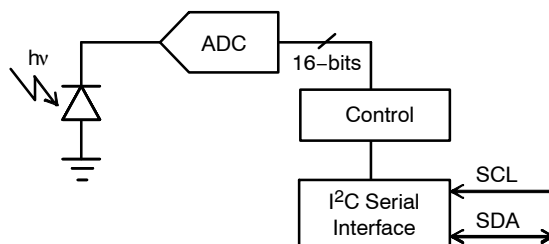
See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

# NOA1302

**Table 1. ORDERING INFORMATION**

Part Number	Package	Shipping Configuration†	Temperature Range
NOA1302DCRG	CTSSOP-8 (Pb-Free)	2500 / Tape & Reel	0°C to 70°C

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.



**Figure 2. Simplified Block Diagram**

**Table 2. PIN FUNCTION DESCRIPTION**

Pin	Pin Name	Description
1, 2, 7, 8	N/C	Not connected, leave this pin unconnected.
3	VSS	Ground pin.
4	SCL	External I²C clock supplied by the I²C master.
5	SDA	Bi-directional data signal for communications between this device and the I²C master.
6	VDD	Power pin.

**Table 3. ABSOLUTE MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Input power supply	VDD	5.5	V
Input voltage range	V <sub>in</sub>	-0.3 to VDD + 0.2	V
Output voltage range	V <sub>out</sub>	-0.3 to VDD + 0.2	V
Maximum Junction Temperature	T <sub>J(max)</sub>	85	°C
Storage Temperature	T <sub>STG</sub>	-40 to 85	°C
ESD Capability, Human Body Model (Note 1)	ESD <sub>HBM</sub>	2.5	kV
ESD Capability, Charged Device Model (Note 1)	ESD <sub>CDM</sub>	750	V
ESD Capability, Machine Model (Note 1)	ESD <sub>MM</sub>	250	V
Moisture Sensitivity Level	MSL	3	-
Lead Temperature Soldering (Note 2)	T <sub>SLD</sub>	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- This device incorporates ESD protection and is tested by the following methods:
  - ESD Human Body Model tested per EIA/JESD22-A114
  - ESD Charged Device Model tested per ESD-STM5.3.1-1999
  - ESD Machine Model tested per EIA/JESD22-A115
  - Latchup Current Maximum Rating: ≤ 100 mA per JEDEC standard: JESD78
- For information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D

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**Table 4. OPERATING RANGES**

Rating	Symbol	Standard Mode		Fast Mode		Unit
		Min	Max	Min	Max	
Power supply voltage	VDD	3.0	3.6	3.0	3.6	V
Power supply current (VDD = 3.3 V)	IDD	325	950	325	950	μA
Low level input voltage (VDD related input levels)	V <sub>IL</sub>	-0.3	0.3 VDD	-0.3	0.3 VDD	V
High level input voltage (VDD related input levels)	V <sub>IH</sub>	0.7 VDD	VDD + 0.2	0.7 VDD	VDD + 0.2	V
Hysteresis of Schmitt trigger inputs (VDD > 2 V)	V <sub>hys</sub>	N/A	N/A	0.05 VDD	-	V
Low level output voltage (open drain) at 3 mA sink current (VDD > 2 V)	V <sub>OL</sub>	0	0.4	0	0.4	V
High level output voltage (with 1 kΩ pullup resistance) at and output current of -20 μA (VDD > 2 V)	V <sub>OH</sub>	VDD - 0.1	N/A	VDD - 0.1	N/A	V
Input current of IO pin with an input voltage between 0.1 VDD and 0.9 VDD	I <sub>I</sub>	-10	10	-10	10	μA
Output low current	I <sub>OL</sub>	-	45	-	45	mA
Capacitance on IO pin	C <sub>I</sub>	-	10	-	10	pF
Operating free-air temperature range	T <sub>A</sub>	0	70	0	70	°C

**Table 5. ELECTRICAL CHARACTERISTICS**

(Unless otherwise specified, these specifications apply over VDD = 3.3 V, 0°C < T<sub>A</sub> < 70°C) (Note 3)

Parameter	Symbol	Standard Mode		Fast Mode		Unit
		Min	Max	Min	Max	
SCL clock frequency	f <sub>SCL</sub>	10	100	100	400	kHz
Hold time for START condition. After this period, the first clock pulse is generated.	t <sub>HD;STA</sub>	4.0	-	0.6	-	μS
Low period of SCL clock	t <sub>LOW</sub>	4.7		1.3		μS
High period of SCL clock	t <sub>HIGH</sub>	4.0		0.6		μS
Data hold time for I <sup>2</sup> C-bus devices	t <sub>HD;DAT_d</sub>	0	3.45	0	0.9	μS
Data set-up time	t <sub>SU;DAT</sub>	250	-	100	-	nS
Rise time of both SDA and SCL (input signals) (Note 4)	t <sub>r_INPUT</sub>	5	300	5	300	nS
Fall time of both SDA and SCL (input signals) (Note 4)	t <sub>f_INPUT</sub>	5	300	5	300	nS
Rise time of SDA output signal (Note 4)	t <sub>r_OUT</sub>	-	1000	-	1000	nS
Fall time of SDA output signal (Note 4)	t <sub>f_OUT</sub>	-	1000	-	1000	nS
Output fall time from V <sub>IHmin</sub> to V <sub>ILmax</sub> with a bus capacitance from 10 pF to 250 pF. (Note 5)	t <sub>of</sub>	2	250	2	250	nS
Set-up time for STOP condition	t <sub>SU;STO</sub>	4.0	-	0.6	-	μS
Bus free time between STOP and START condition	t <sub>BUF</sub>	4.7	-	1.3	-	μS
Capacitive load for each bus line (including all parasitic capacitance)	C <sub>L</sub>	-	250	-	250	pF
Noise margin at the low level for each connected device (including hysteresis)	V <sub>nL</sub>	0.1 VDD	-	0.1 VDD	-	V
Noise margin at the high level for each connected device (including hysteresis)	V <sub>nH</sub>	0.2 VDD	-	0.2 VDD	-	V

3. Refer to Figure 3 for more information on AC characteristics

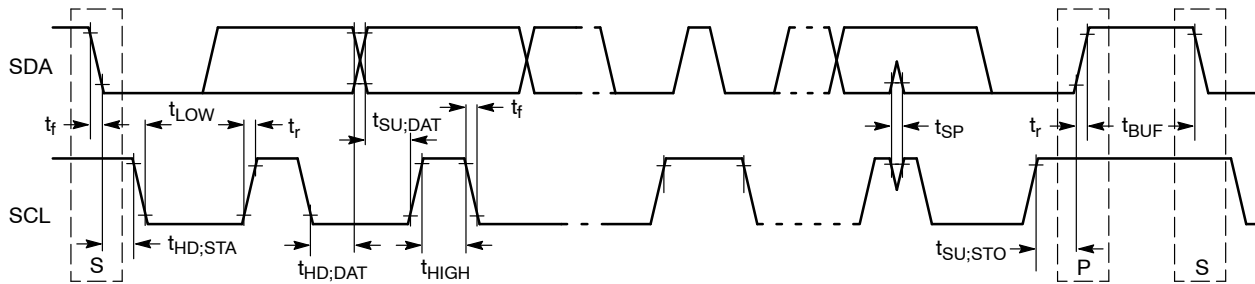
4. The rise time and fall time are measured with a pull-up resistor R<sub>p</sub> = 1 kΩ and C<sub>b</sub> of 250 pF (including all parasitic capacitances).

5. C<sub>b</sub> = capacitance of one bus line, maximum value of which including all parasitic capacitances should be less than 250 pF.

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**Table 6. OPTICAL CHARACTERISTICS** (Unless otherwise specified, these specifications are for VDD = 3.3 V, T<sub>A</sub> = 25°C)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Irradiance responsivity	$\lambda_p$ (see Figure 5)	R <sub>e</sub>		545		nM
Illuminance responsivity	Incandescent light source: Ev = 100 lux (see Figure 6)	R <sub>v</sub>		150		Counts
	Incandescent light source: Ev = 1000 lux (see Figure 6)			1480		
Illuminance responsivity	Fluorescent light source: Ev = 100 lux (see Figure 7)	R <sub>v</sub>		130		Counts
	Fluorescent light source: Ev = 1000 lux (see Figure 7)			1290		
Dark current	Ev = 0 lux (see Figure 9)			2		Counts



**Figure 3. AC Characteristics**

TYPICAL CHARACTERISTICS

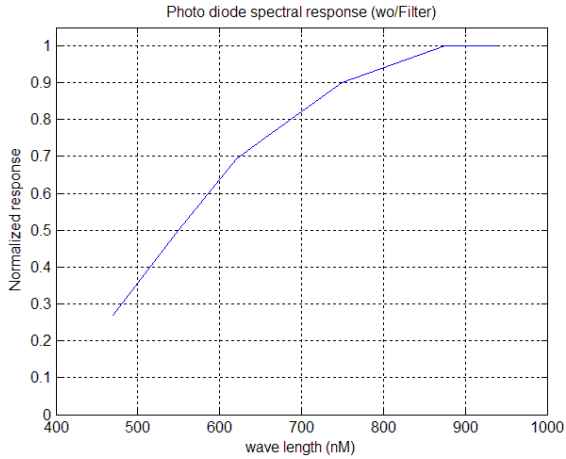


Figure 4. Photo Diode Spectral Response (Without Filter)

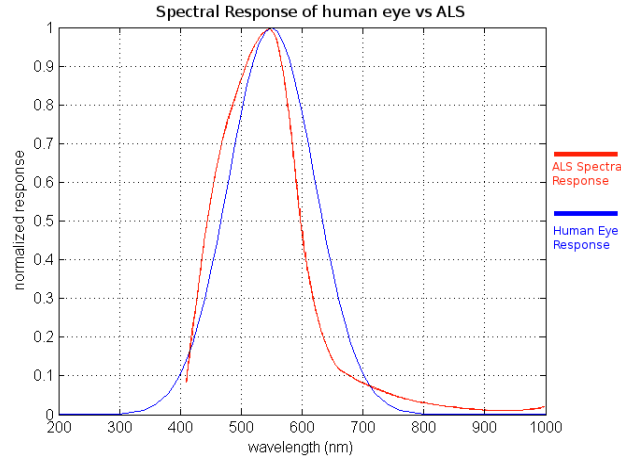


Figure 5. Human Eye vs. NOA1302 Spectral Response

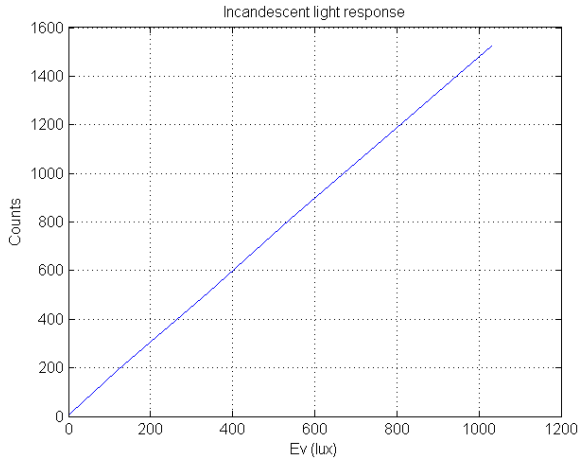


Figure 6. Incandescent Light Response (200 ms Integration)

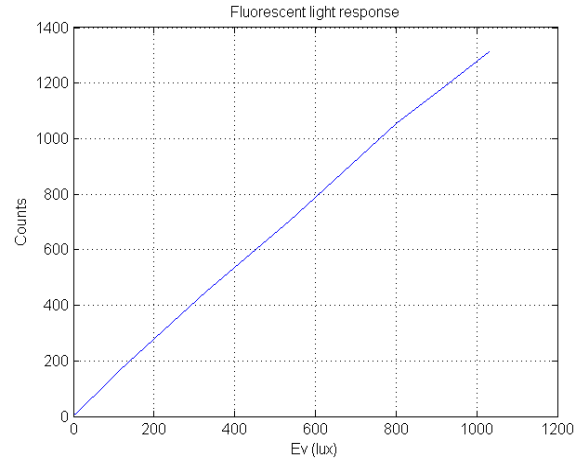


Figure 7. Fluorescent Light Response (200 ms Integration)

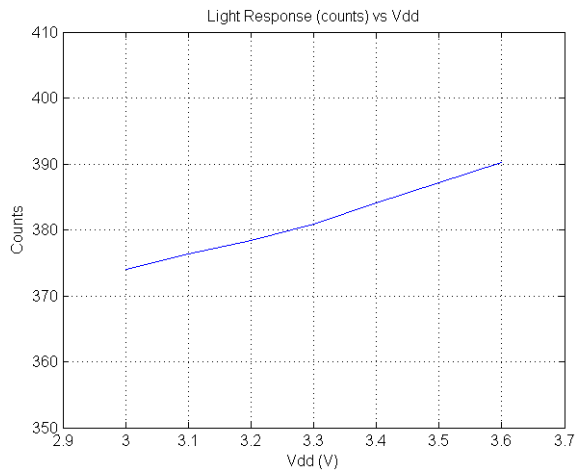


Figure 8. Light Response vs. VDD

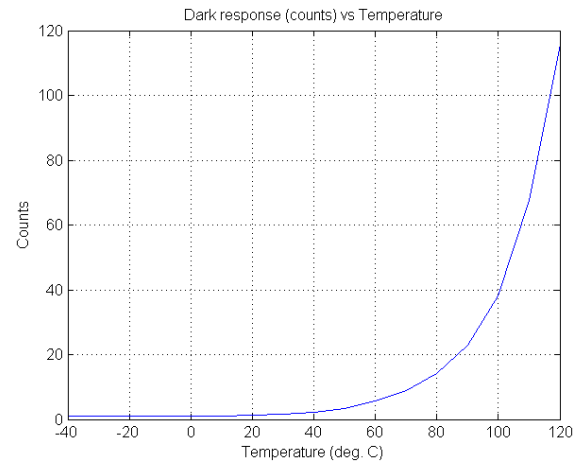


Figure 9. Dark Counts vs. Temperature (200 ms Integration)

TYPICAL CHARACTERISTICS

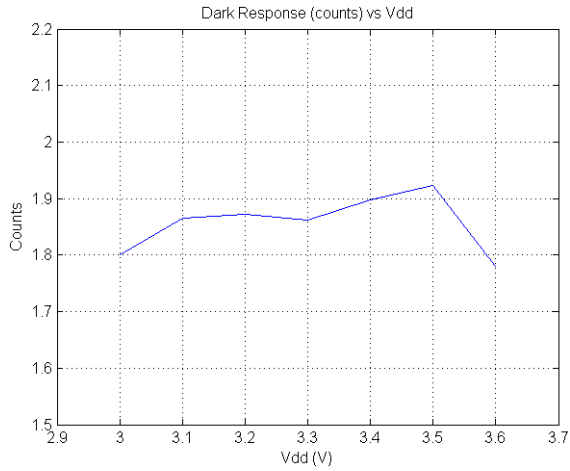


Figure 10. Dark Counts vs. Vdd

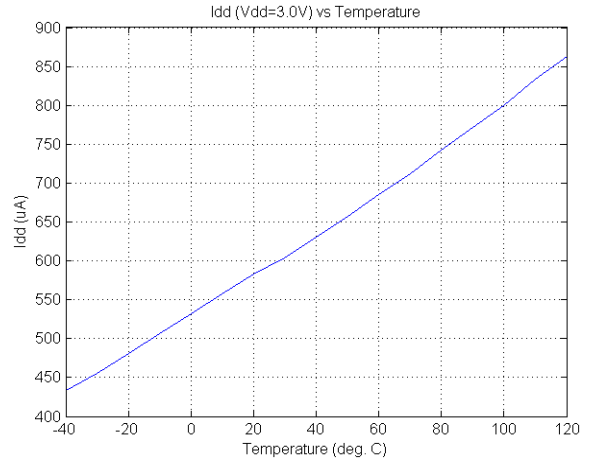


Figure 11. Idd vs. Temperature

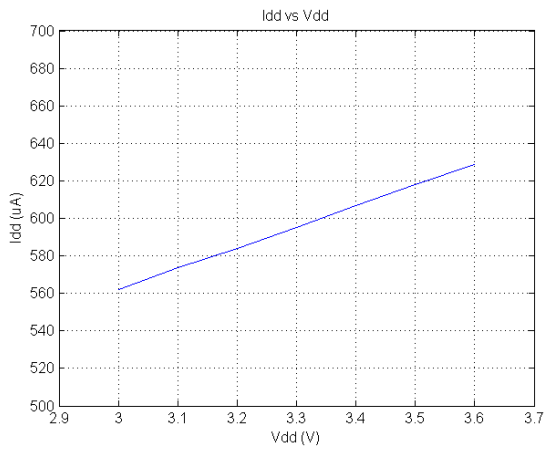


Figure 12. Idd vs.Vdd

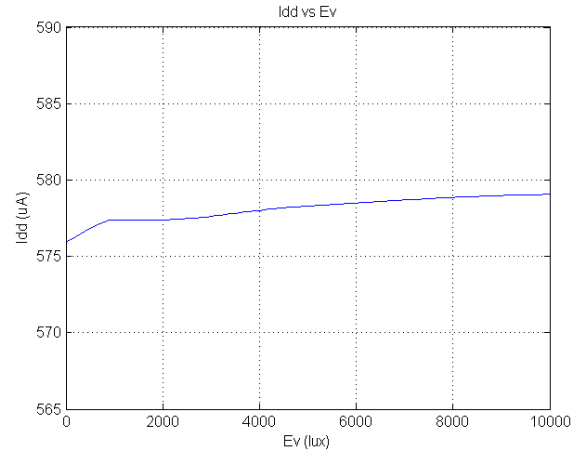


Figure 13. Idd vs Ev

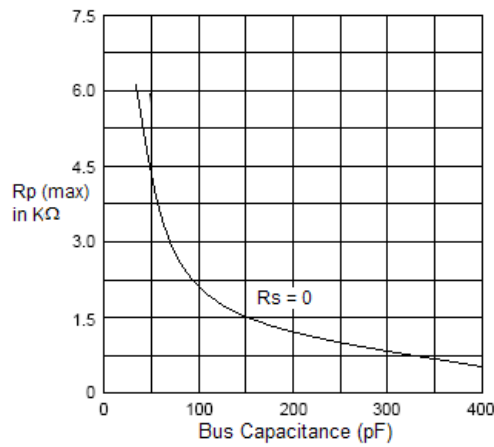


Figure 14. Maximum Value of Rp (in kΩ) as a function of Bus Capacitance (in pF)

## DESCRIPTION OF OPERATION

**Ambient Light Sensor Architecture**

The NOA1302 employs a sensitive photo diode fabricated in ON Semiconductor's standard CMOS process technology. The major components of this sensor are as shown in Figure 2. The photons which are to be detected pass through an ON Semiconductor proprietary color filter limiting extraneous photons and thus performing as a band pass filter on the incident wave front. The filter only transmits photons in the visible spectrum which are primarily detected by the human eye. The photo response of this sensor is as shown in Figure 5.

The ambient light signal detected by the photo diode is converted to digital signal using a *variable slope integrating* ADC with a resolution of 16-bits, unsigned. The ADC value is provided to the control block connected to the I<sup>2</sup>C interface block.

Equation 1 shows the relationship of output counts  $C_{nt}$  as a function of integration constant  $I_k$ , integration time  $T_{int}$  (in seconds) and the intensity of the ambient light,  $I_L$  (in lux), at room temperature (25°C).

$$I_L = \frac{C_{nt}}{(I_k \cdot T_{int})} \quad (\text{eq. 1})$$

Where:

$I_k = 6.67$  (for fluorescent light)

$I_k = 7.5$  (for incandescent light)

Hence the intensity of the ambient fluorescent light (in lux):

$$I_L = \frac{C_{nt}}{(6.67 \cdot T_{int})} \quad (\text{eq. 2})$$

and the intensity of the ambient incandescent light (in lux):

$$I_L = \frac{C_{nt}}{(7.5 \cdot T_{int})} \quad (\text{eq. 3})$$

For example let:

$C_{nt} = 1200$

$T_{int} = 200 \text{ mS}$

Intensity of ambient incandescent light,  $I_L$  (in lux):

$$I_L = \frac{1200}{(7.5 \cdot 200 \text{ mS})} \quad (\text{eq. 4})$$

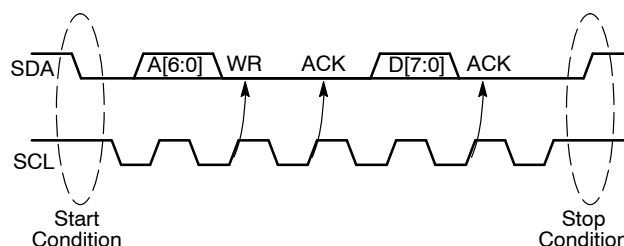
$I_L = 800 \text{ lux}$

**I<sup>2</sup>C Interface**

The NOA1302 operates on the I<sup>2</sup>C bus as a slave device. The I<sup>2</sup>C address is fixed at 0x39 (hexadecimal 39). Registers can be programmed by sending commands over an I<sup>2</sup>C bus. Ambient light intensity count value can be obtained by reading registers. The ambient light intensity count is 16 bits, hence two I<sup>2</sup>C read operations are needed. This device supports both standard (100 Kbit/s) and fast mode (400 Kbit/s) of operation on the I<sup>2</sup>C bus.

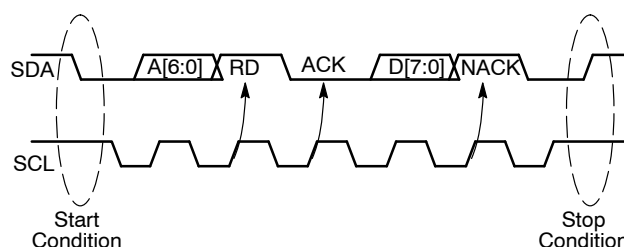
Figure 15 shows an I<sup>2</sup>C write operation. To write to an internal register of the NOA1302 a write command must be sent by an I<sup>2</sup>C master. The write command begins with a start condition. After the start condition, seven bits of address are

sent MSB first. RD/WR\_ command bit follows the address bits. Upon receiving a valid address the device responds by driving SDA low for an ACK. After receiving an ACK, the I<sup>2</sup>C master sends eight bits of data with MSB first. Upon receiving eight bits of data the NOA1302 generates an ACK. The I<sup>2</sup>C master terminates this write command with a stop condition.



**Figure 15. I<sup>2</sup>C Write Command**

Figure 16 shows an I<sup>2</sup>C read command sent by the master to the slave device. The I<sup>2</sup>C read command begins with a start condition. After the start condition, seven bits of address are sent by the master MSB first, followed by the RD/WR\_ command bit. For a read command the RD/WR\_ bit is high. Upon receiving the address bits and RD/WR\_ command bits the device responds with an ACK. After sending an ACK, the device sends eight bits of data MSB first. After receiving the data, the master terminates this transaction by issuing a NACK command to indicate that the master only wanted to read one byte from the device. The master generates a stop condition to end this transaction. Repeated START condition is not supported. Each I<sup>2</sup>C transaction must be terminated with a STOP condition after all required bits have been transmitted and received.



**Figure 16. I<sup>2</sup>C Read Command**

**Programmer's Model**

Ambient light intensity count is obtained from the the NOA1302 by issuing a fixed sequence of I<sup>2</sup>C commands. Integration time is programmable by writing different values to the integration time register. The following sections describe what a programmer needs to know about issuing commands to the chip and register access.

**Integration Time Register**

Table 7 describes integration time register which controls the exposure time. This register has three bits, EC[2:0] which control the duration of the integration time.



**Table 7. INTEGRATION TIME REGISTER**

EC[2,1,0]	Operation	Integration Time
000	Normal mode of operation	400 ms
001	Normal mode of operation	200 ms (Default)
010	Normal mode of operation	100 ms
011	Test mode	16.7 ms
100	Simulation test mode use only	1.0 ms
101	Reserved for future use	
110	Reserved for future use	
111	Reserved for future use	

**Programming Sequence and Command Summary**

This section describes supported commands and programming sequence. The NOA1302 only supports single byte write and a single byte read I<sup>2</sup>C commands. Ambient light intensity count is 16 bits wide, thus two I<sup>2</sup>C read commands are needed.

Table 8 describes supported commands. All of these commands have to be sent to the fixed address (0x39).

**Table 8. DEVICE COMMANDS**

Command	Function
0x00h	Start reading ADC data
0x03h	Complete reading ADC data
0x1Dh	Change EC[0] to 0
0x18h	Reset EC[2:0] to default value (001)
0x43h	Prepare ADC LS byte for reading
0x83h	Prepare ADC MS byte for reading
0x88h	Change EC[1] to 1
0x90h	Change EC[2] to 1

**Programming Sequence**

To read 16 bits wide ambient light intensity count, the following commands must be issued in sequence:

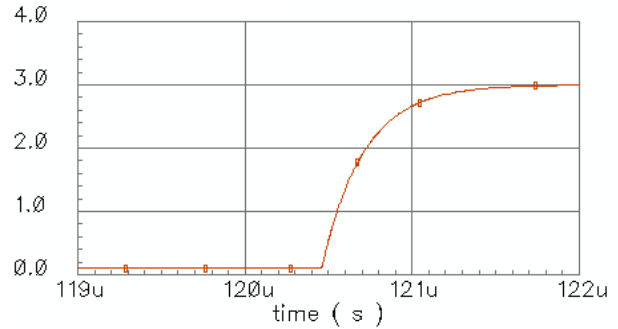
1. Send write command 0x00h to start the ADC conversion cycle.
2. Send write command 0x03h to complete the ADC cycle.
3. Send write command 0x43h to prepare the LS byte for reading.
4. Send read byte command, returns LS byte of count.
5. Send write command 0x83h to prepare the MS byte for reading.
6. Send read byte command, returns MS byte of count.

To change the integration time, for example to 100 ms, the following commands must be used in sequence:

1. Send write command 0x1Dh to set EC[0] = 0.
2. Send write command 0x88h to set EC[1] = 1, now EC[2:0] = 010.

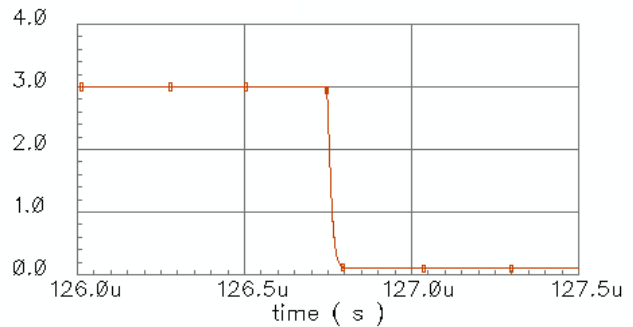
**Rise and Fall Time of SDA (Output)**

Proper operation of the I<sup>2</sup>C bus depends on keeping the bus capacitance low and selecting suitable pull-up resistor values. Figure 17 and Figure 18 show the rise and fall time on SDA in output mode under maximum load conditions. The measurement set-up is shown in Figure 19. Figure 14 shows the maximum value of the pull-up resistor (R<sub>p</sub>) as a function of the I<sup>2</sup>C data bus capacitance.



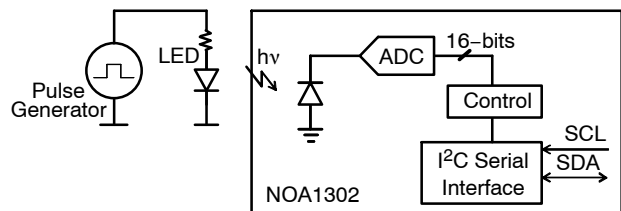
R<sub>p</sub> = 1 kΩ  
 C<sub>L</sub> = 250 pF (including all parasitic caps)  
 t<sub>r</sub> = 530 ns

**Figure 17. SDA Rise Time (t<sub>r</sub>)**



R<sub>p</sub> = 1 kΩ  
 C<sub>L</sub> = 250 pF (including all parasitic caps)  
 t<sub>f</sub> = 21 ns

**Figure 18. SDA Fall Time (t<sub>f</sub>)**

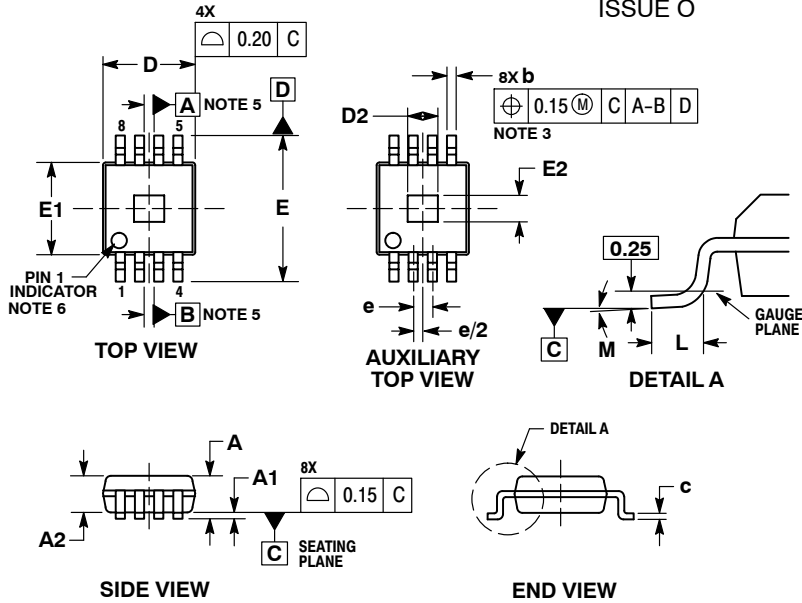


**Figure 19. Measurement Set-up**

# NOA1302

## PACKAGE DIMENSIONS

CTSSOP8 3x3  
CASE 949AA-01  
ISSUE O

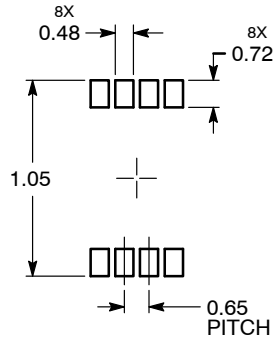


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION  $b$  DOES NOT INCLUDE DAMBAR PROTRUSION AND IS DETERMINED BETWEEN 0.08 AND 0.15 MM FROM THE LEAD TIP.
4. DIMENSIONS  $D$  AND  $E1$  DOES NOT INCLUDE MOLD PROTRUSIONS, TIE BAR BURRS, GATE BURRS OR FLASH. END FLASH SHALL NOT EXCEED 0.25 PER SIDE. DIMENSIONS  $D$  AND  $E1$  DO INCLUDE ANY MOLD CAVITY MISMATCH AND ARE DETERMINED AT THE GAUGE PLANE.
5. DATUMS  $A$  AND  $B$  TO BE DETERMINED AT THE GAUGE PLANE.
6. DETAILS OF THE PIN 1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THIS ZONE.

DIM	MILLIMETERS	
	MIN	MAX
A	---	1.10
A1	0.00	0.14
A2	0.73	0.93
b	0.24	0.39
c	0.13	0.24
D	3.00 BSC	
D2	0.66	1.37
E	4.90 BSC	
E1	3.00 BSC	
E2	0.41	1.37
e	0.65 BSC	
L	0.39	0.67
M	0°	8°

### SOLDERING FOOTPRINT\*



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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